

Search Notes 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/048,007	WATANABE ET AL.	
				Examiner	Art Unit	
				Yuwen Pan	2682	
SEARCHED				SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
Class	Subclass	Date	Examiner		DATE	EXMR
455	404.1,404. 2,412.2, 414.4,	9/14/2004	YW			
	419					
	423					
	66.1					
UPDATE	SEARCH	8/10/2005	YW			
UPDATE	SEARCH	12/29/2005	YW			
340	441,459	10/31/06	YW			
	461					
701	29,31,35					
702	184, 34					
	179					
INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
see search history		10/31/06	YW			